

**Search Notes**

Application/Control No.

10/725,133

Examiner

W. Patty Chen

Applicant(s)/Patent under  
Reexamination

LEE ET AL.

Art Unit

2871

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Reviewed previously cited references	5/11/2007	WPC
349/141 combined with key words search of all databases in EAST	5/11/2007	WPC